

NTC thermistors for temperature measurement

Probe assemblies, pipe mounted sensors

Series/Type: B58100
Date: March 2006

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Temperature measurement

Probe assemblies T120

Applications

■ Pipe mounted sensor for measurement of fluid temperature in pipes

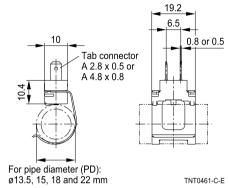
Features

- Short response time through glass-encapsulated NTC thermistor
- Fast and easy mounting

Options

- Available for pipes with diameter 13.5, 15, 18 and 22 mm
- Alternative resistance ratings available on request
- Alternative fast-on plug terminals 2.8 x 0.5 or 4.8 x 0.8 mm available

Dimensional drawing



B58100

Dimensions in mm

Delivery mode

Bulk (standard)

General technical data

Climatic category	(IEC 60068-1)		5/100/21	
Maximum power	(at 25 °C)	P ₂₅	18	mW
Resistance tolerance		$\Delta R_R/R_R$	±3.6	%
Rated temperature		T_R	60	°C
Thermal time constant	(measured on pipe)		<5	s
Insulation resistance	(V = 100 VDC, t = 1 s)	R _{ins}	>10	$M\Omega$
Dissipation factor	(in air)	δ_{th}	approx. 2.1	mW/K
Test voltage	(t = 1 min)	V _{test}	500	VAC

Electrical specification and ordering codes

R ₂₅	No. of	B _{25/100}	for pipe diameter	Ordering code
	R/T characteristic			
Ω		K	mm	
10 k	8417	4006 ±2%	13.5	B58100A0405A000
10 k	8417	4006 ±2%	15	B58100A0528A000
10 k	8417	4006 ±2%	18	B58100A0406A000
10 k	8417	4006 ±2%	22	B58100A0439A000
10 k	8407	3497 ±1%	13.5	B58100A0527A000
10 k	8407	3497 ±1%	18	B58100A0506A000
10 k	8407	3497 ±1%	22	B58100A0531A000



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Reliability data

Test	Standard	Test conditions	$\Delta R_{100}/R_{100}$ (typical)	Remarks
Storage in dry heat	IEC 60068-2-2	Storage at upper category temperature T: 100 °C t: 500 h	< 3%	No visible damage
Storage in damp heat, steady state	IEC 60068-2-78	Temperature of air: 85 °C Relative humidity of air: 85% Duration: 21 days	< 5%	No visible damage
Rapid temperature cycling	IEC 60068-2-14	Lower test temperature: 5 °C Upper test temperature: 85 °C Number of cycles: 100	< 3%	No visible damage
Thermal overload		Short time overload: 125 °C t: 10 h	< 3%	No visible damage



Tem	nera	ture	measi	urement	

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Probe assemblies

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R/T characteristics

	B58100A0405A000					
R/T No.	8417					
T (°C)	$B_{25/100} = 4006$	K_1 , $R_{25} = 1000$	0Ω , $T_R = 60$	$^{\circ}$ C, $\Delta R_{R}/R_{R} = \pm$	3.6%	
	$R_{nom}[\Omega]$	$R_{min}[\Omega]$	$R_{max}[\Omega]$	$\Delta R_R/R_R[\pm\%]$	ΔT[±°C]	α (%/K)
5.0	25607	23393	27821	8.6	1.7	5.0
10.0	20017	18397	21637	8.1	1.7	4.8
15.0	15768	14576	16961	7.6	1.6	4.7
20.0	12513	11630	13396	7.1	1.5	4.6
25.0	10000	9343	10657	6.6	1.5	4.4
30.0	8045	7555	8535	6.1	1.4	4.3
35.0	6514	6146	6881	5.6	1.4	4.2
40.0	5306	5030	5583	5.2	1.3	4.0
45.0	4348	4140	4556	4.8	1.2	3.9
50.0	3583	3426	3740	4.4	1.1	3.8
55.0	2968	2850	3086	4.0	1.1	3.7
60.0	2472	2383	2561	3.6	1.0	3.6
65.0	2068	1986	2150	4.0	1.1	3.5
70.0	1739	1664	1814	4.3	1.3	3.4
75.0	1469	1400	1537	4.7	1.4	3.3
80.0	1246	1183	1308	5.0	1.5	3.2
85.0	1061	1005	1118	5.4	1.7	3.2
90.0	907.8	856.3	959.4	5.7	1.8	3.1
95.0	779.5	732.8	826.2	6.0	2.0	3.0
100.0	671.8	629.5	714.2	6.3	2.1	2.9
105.0	581.1	542.7	619.5	6.6	2.3	2.9
110.0	504.4	469.6	539.2	6.9	2.5	2.8
115.0	439.3	407.7	470.9	7.2	2.6	2.7
120.0	383.9	355.2	412.5	7.5	2.8	2.7

	B58100A05	B58100A0528A000					
R/T No.	8417						
T (°C)	$B_{25/100} = 400$	$6 \text{ K}, \ R_{25} = 100$	Ω 000 Ω , $T_R = 60$	$0 ^{\circ}\text{C}, \Delta R_R/R_R = 1$	± 3.6%		
	$R_nom[\Omega]$	$R_{min}[\Omega]$	$R_{max}[\Omega]$	$\Delta R_R/R_R[\pm\%]$	$\Delta T[\pm^{\circ}C]$	α (%/K)	
5.0	25607	23393	27821	8.6	1.7	5.0	
10.0	20017	18397	21637	8.1	1.7	4.8	
15.0	15768	14576	16961	7.6	1.6	4.7	
20.0	12513	11630	13396	7.1	1.5	4.6	
25.0	10000	9343	10657	6.6	1.5	4.4	
30.0	8045	7555	8535	6.1	1.4	4.3	
35.0	6514	6146	6881	5.6	1.4	4.2	
40.0	5306	5030	5583	5.2	1.3	4.0	
45.0	4348	4140	4556	4.8	1.2	3.9	



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Probe assemblies	T120

-	B58100A0528A000					
R/T No.	8417					
T (°C)	$B_{25/100} = 4006 \text{ K}, \ R_{25} = 10000 \ \Omega, \ T_R = 60 \ ^{\circ}\text{C}, \ \Delta R_R/R_R = \pm 3.6\%$					
	$R_nom[\Omega]$	$R_{min}[\Omega]$	$R_{max}[\Omega]$	$\Delta R_R/R_R[\pm\%]$	ΔT[±°C]	α (%/K)
50.0	3583	3426	3740	4.4	1.1	3.8
55.0	2968	2850	3086	4.0	1.1	3.7
60.0	2472	2383	2561	3.6	1.0	3.6
65.0	2068	1986	2150	4.0	1.1	3.5
70.0 75.0	1739	1664	1814	4.3 4.7	1.3 1.4	3.4 3.3
	1469	1400	1537			
80.0	1246	1183	1308	5.0 5.4	1.5	3.2
85.0 90.0	1061 907.8	1005 856.3	1118 959.4	5.7	1.7 1.8	3.2 3.1
95.0	779.5	732.8	826.2	6.0	2.0	3.0
100.0	671.8	629.5	714.2	6.3	2.1	2.9
105.0	581.1	542.7	619.5	6.6	2.3	2.9
110.0	504.4	469.6	539.2	6.9	2.5	2.8
115.0	439.3	407.7	470.9	7.2	2.6	2.7
120.0	383.9	355.2	412.5	7.5	2.8	2.7
	B58100A040	6A000				
R/T No.	8417					
T (°C)	$B_{25/100} = 4006$	K_1 , $R_{25} = 1000$	$0 \Omega, T_{R} = 60^{\circ}$	$^{\circ}$ C, $\Delta R_{R}/R_{R} = \pm$	3.6%	
	$R_{nom}[\Omega]$	$R_{min}[\Omega]$	$R_{max}[\Omega]$	$\Delta R_R/R_R[\pm\%]$	ΔT[±°C]	α (%/K)
5.0	25607	23393	27821	8.6	1.7	5.0
10.0	20017	18397	21637	8.1	1.7	4.8
15.0	15768	14576	16961	7.6	1.6	4.7
20.0	12513	11630	13396	7.1	1.5	4.6
25.0	10000	9343	10657	6.6	1.5	4.4
30.0	8045	7555	8535	6.1	1.4	4.3
35.0	6514	6146	6881	5.6	1.4	4.2
40.0	5306	5030	5583	5.2 4.8	1.3 1.2	4.0 3.9
45.0 50.0	4348 3583	4140 3426	4556 3740	4.6	1.1	3.8
55.0 60.0	2968	2850	3086 2561	4.0 3.6	1.1 1.0	3.7 3.6
65.0	2472 2068	2383 1986	2150	4.0	1.1	3.5
70.0	1739	1664	1814	4.3	1.3	3.4
75.0	1469	1400	1537	4.7	1.4	3.3
80.0	1246	1183	1308	5.0	1.5	3.2
85.0	1061	1005	1118	5.4	1.7	3.2
90.0	907.8	856.3	959.4	5.7	1.8	3.1
95.0	779.5	732.8	826.2	6.0	2.0	3.0



Temperature measurement	B38100
Probe assemblies	T120

	1					
	B58100A040	6A000				
R/T No.	8417					
T (°C)	$B_{25/100} = 4006$	$R_{25} = 1000$	0Ω , $T_R = 60$	$^{\circ}$ C, $\Delta R_{R}/R_{R} = \pm \frac{1}{2}$	± 3.6%	
	$R_nom[\Omega]$	$R_{min}[\Omega]$	$R_{max}[\Omega]$	$\Delta R_R/R_R[\pm\%]$	ΔT[±°C]	α (%/K)
100.0	671.8	629.5	714.2	6.3	2.1	2.9
105.0	581.1	542.7	619.5	6.6	2.3	2.9
110.0	504.4	469.6	539.2	6.9	2.5	2.8
115.0	439.3	407.7	470.9	7.2	2.6	2.7
120.0	383.9	355.2	412.5	7.5	2.8	2.7
	B58100A043	9A000				
R/T No.	8417					
T (°C)	B _{25/100} = 4006	K, R ₂₅ = 1000	$0 \Omega, T_{R} = 60^{\circ}$	$^{\circ}$ C, $\Delta R_{R}/R_{R} = \pm$	± 3.6%	
	$R_{nom}[\Omega]$	$R_{min}[\Omega]$	$R_{max}[\Omega]$	$\Delta R_R/R_R[\pm\%]$	ΔT[±°C]	α (%/K)
5.0	25607	23393	27821	8.6	1.7	5.0
10.0	20017	18397	21637	8.1	1.7	4.8
15.0	15768	14576	16961	7.6	1.6	4.7
20.0	12513	11630	13396	7.1	1.5	4.6
25.0	10000	9343	10657	6.6	1.5	4.4
30.0	8045	7555	8535	6.1	1.4	4.3
35.0	6514	6146	6881	5.6	1.4	4.2
40.0	5306	5030	5583	5.2	1.3	4.0
45.0	4348	4140	4556	4.8	1.2	3.9
50.0	3583	3426	3740	4.4	1.1	3.8
55.0	2968	2850	3086	4.0	1.1	3.7
60.0	2472	2383	2561	3.6	1.0	3.6
65.0	2068	1986	2150	4.0	1.1	3.5
70.0	1739	1664	1814	4.3	1.3	3.4
75.0	1469	1400	1537	4.7	1.4	3.3
80.0	1246	1183	1308	5.0	1.5	3.2
85.0	1061	1005	1118	5.4	1.7	3.2
90.0	907.8	856.3	959.4	5.7	1.8	3.1
95.0	779.5	732.8	826.2	6.0	2.0	3.0
100.0	671.8	629.5	714.2	6.3	2.1	2.9
105.0	581.1	542.7	619.5	6.6	2.3	2.9
110.0	504.4	469.6	539.2	6.9	2.5	2.8
115.0	439.3	407.7	470.9	7.2	2.6	2.7
120.0	383.9	355.2	412.5	7.5	2.8	2.7



remperature measurement	D36100
Probe assemblies	T120

	B58100A0527A000							
R/T No.	8407							
T (°C)	$B_{25/100} = 3497 \text{ K}, \ R_{25} = 10000 \ \Omega, \ T_R = 60 \ ^{\circ}\text{C}, \ \Delta R_R/R_R = \pm 3.6\%$							
	$R_{nom}[\Omega]$	$R_{min}[\Omega]$	$R_{max}[\Omega]$	$\Delta R_R/R_R[\pm\%]$	ΔT[±°C]	α (%/K)		
5.0	22468	21171	23765	5.8	1.3	4.3		
10.0	18187	17180	19194	5.5	1.3	4.2		
15.0	14813	14026	15600	5.3	1.3	4.0		
20.0	12136	11518	12755	5.1	1.3	3.9		
25.0	10000	9512	10488	4.9	1.3	3.8		
30.0	8284	7897	8672	4.7	1.3	3.7		
35.0	6899	6590	7209	4.5	1.2	3.6		
40.0	5774	5526	6022	4.3	1.2	3.5		
45.0	4856	4656	5056	4.1	1.2	3.4		
50.0	4103	3941	4264	3.9	1.2	3.3		
55.0	3482	3351	3613	3.8	1.2	3.2		
60.0	2967	2860	3074	3.6	1.1	3.2		
65.0	2539	2444	2635	3.8	1.2	3.1		
70.0	2182	2096	2267	3.9	1.3	3.0		
75.0	1882	1805	1958	4.1	1.4	2.9		
80.0	1629	1560	1698	4.2	1.5	2.8		
85.0	1415	1353	1477	4.4	1.6	2.8		
90.0	1234	1178	1289	4.5	1.7	2.7		
95.0	1079	1029	1129	4.6	1.8	2.6		
100.0	946.6	901.4	991.8	4.8	1.8	2.6		
105.0	833.1	792.3	874.0	4.9	1.9	2.5		
110.0	735.5	698.5	772.5	5.0	2.0	2.5		
115.0	651.1	617.6	684.7	5.2	2.1	2.4		
120.0	578.1	547.6	608.6	5.3	2.2	2.4		

	B58100A0506A000						
R/T No.	8407						
T (°C)	$B_{25/100} = 3497 \text{ K}, \ R_{25} = 10000 \ \Omega, \ T_R = 60 \ ^{\circ}\text{C}, \ \Delta R_R/R_R = \pm \ 3.6\%$						
	$R_nom[\Omega]$	$R_{min}[\Omega]$	$R_{max}[\Omega]$	$\Delta R_R/R_R[\pm\%]$	ΔT[±°C]	α (%/K)	
5.0	22468	21171	23765	5.8	1.3	4.3	
10.0	18187	17180	19194	5.5	1.3	4.2	
15.0	14813	14026	15600	5.3	1.3	4.0	
20.0	12136	11518	12755	5.1	1.3	3.9	
25.0	10000	9512	10488	4.9	1.3	3.8	
30.0	8284	7897	8672	4.7	1.3	3.7	
35.0	6899	6590	7209	4.5	1.2	3.6	
40.0	5774	5526	6022	4.3	1.2	3.5	
45.0	4856	4656	5056	4.1	1.2	3.4	
50.0	4103	3941	4264	3.9	1.2	3.3	



Temperature measurement	B58100
Probe assemblies	T120

	B58100A0506A000						
R/T No.	8407						
T (°C)	$B_{25/100} = 3497 \; K, \;\; R_{25} = 10000 \; \Omega, \;\; T_R = 60 \; ^{\circ}C, \;\; \Delta R_R/R_R = \pm \; 3.6\%$						
	$R_nom[\Omega]$	$R_{min}[\Omega]$	$R_{max}[\Omega]$	$\Delta R_R/R_R[\pm\%]$	ΔT[±°C]	α (%/K)	
55.0 60.0 65.0 70.0 75.0 80.0 85.0 90.0 95.0 100.0 105.0 110.0	3482 2967 2539 2182 1882 1629 1415 1234 1079 946.6 833.1 735.5	3351 2860 2444 2096 1805 1560 1353 1178 1029 901.4 792.3 698.5	3613 3074 2635 2267 1958 1698 1477 1289 1129 991.8 874.0 772.5	3.8 3.6 3.8 3.9 4.1 4.2 4.4 4.5 4.6 4.8 4.9 5.0	1.2 1.1 1.2 1.3 1.4 1.5 1.6 1.7 1.8 1.8 1.9 2.0	3.2 3.2 3.1 3.0 2.9 2.8 2.7 2.6 2.6 2.5 2.5	
115.0	651.1	617.6	684.7	5.2	2.1	2.4	
120.0	578.1	547.6	608.6	5.3	2.2	2.4	
	B58100A0531A000						
R/T No.	8407						
T (°C)	$B_{25/100} = 3497 \text{ K}, \ R_{25} = 10000 \ \Omega, \ T_R = 60 \ ^{\circ}\text{C}, \ \Delta R_R/R_R = \pm 3.6\%$						
	$R_{nom}[\Omega]$	$R_{min}[\Omega]$	$R_{max}[\Omega]$	$\Delta R_R/R_R[\pm\%]$	ΔT[±°C]	α (%/K)	
5.0 10.0 15.0 20.0 25.0	22468 18187 14813 12136 10000	21171 17180 14026 11518 9512	23765 19194 15600 12755 10488	5.8 5.5 5.3 5.1 4.9	1.3 1.3 1.3 1.3	4.3 4.2 4.0 3.9 3.8	
30.0 35.0 40.0 45.0 50.0 55.0 60.0 65.0 70.0 75.0 80.0 85.0 90.0 95.0	8284 6899 5774 4856 4103 3482 2967 2539 2182 1882 1629 1415 1234 1079 946.6	7897 6590 5526 4656 3941 3351 2860 2444 2096 1805 1560 1353 1178 1029 901.4	8672 7209 6022 5056 4264 3613 3074 2635 2267 1958 1698 1477 1289 1129 991.8	4.7 4.5 4.3 4.1 3.9 3.8 3.6 3.8 3.9 4.1 4.2 4.4 4.5 4.6 4.8	1.3 1.2 1.2 1.2 1.2 1.2 1.1 1.2 1.3 1.4 1.5 1.6 1.7 1.8	3.7 3.6 3.5 3.4 3.3 3.2 3.2 3.1 3.0 2.9 2.8 2.7 2.6 2.6	



Temperature measurement	B58100
Probe assemblies	T120

	B58100A0531A000							
R/T No.	8407							
T (°C)	$B_{25/100} = 3497 \text{ K}, \ R_{25} = 10000 \ \Omega, \ T_R = 60 \ ^{\circ}\text{C}, \ \Delta R_R/R_R = \pm 3.6\%$							
	$R_nom[\Omega]$	$R_{min}[\Omega]$	$R_{max}[\Omega]$	$\Delta R_R/R_R[\pm\%]$	ΔT[±°C]	α (%/K)		
105.0	833.1	792.3	874.0	4.9	1.9	2.5		
110.0	735.5	698.5	772.5	5.0	2.0	2.5		
115.0	651.1	617.6	684.7	5.2	2.1	2.4		
120.0	578.1	547.6	608.6	5.3	2.2	2.4		



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Cautions and warnings

General

See "Important notes" at the end of this document.

Storage

- Store thermistors only in original packaging. Do not open the package before storage.
- Storage conditions in original packaging: storage temperature −25 °C ... +45 °C, relative humidity ≤75% annual mean, maximum 95%, dew precipitation is inadmissible.
- Do not store SMDs where they are exposed to heat or direct sunlight. Otherwise, the packing material may be deformed or SMDs may stick together, causing problems during mounting.
- Avoid contamination of thermistors surface during storage, handling and processing.
- Avoid storage of thermistor in harmful environments like corrosive gases (SOx, Cl etc).
- After opening the factory seals, such as polyvinyl-sealed packages, use the SMDs as soon as possible.
- Solder thermistors after shipment from EPCOS within the time specified:

SMDs: 12 months

Leaded components: 24 months

Handling

- NTC thermistors must not be dropped. Chip-offs must not be caused during handling of NTCs.
- Components must not be touched with bare hands. Gloves are recommended.
- Avoid contamination of thermistor surface during handling.

Soldering

- Use resin-type flux or non-activated flux.
- Insufficient preheating may cause ceramic cracks.
- Rapid cooling by dipping in solvent is not recommended.
- Complete removal of flux is recommended.

Mounting

- When NTC thermistors are encapsulated with sealing material or overmolded with plastic material, the precautions given in chapter "Mounting instructions", "Sealing, potting and overmolding" must be observed.
- Electrode must not be scratched before/during/after the mounting process.
- Contacts and housings used for assembly with thermistor have to be clean before mounting.
- During operation, the thermistor's surface temperature can be very high (ICL). Ensure that adjacent components are placed at a sufficient distance from the thermistor to allow for proper cooling of the thermistors.
- Ensure that adjacent materials are designed for operation at temperatures comparable to the surface temperature of the thermistor. Be sure that surrounding parts and materials can withstand this temperature.
- Make sure that thermistors (ICLs) are adequately ventilated to avoid overheating.
- Avoid contamination of thermistor surface during processing.



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Operation

- Use thermistors only within the specified operating temperature range.
- Use thermistors only within the specified voltage and current ranges (ICLs).
- Environmental conditions must not harm the thermistors. Use thermistors only in normal atmospheric conditions.
- Contact of NTC thermistors with any liquids and solvents should be prevented. It must be ensured that no water enters the NTC thermistor (e.g. through plug terminals). For measurement purposes (checking the specified resistance vs. temperature), the component must not be immersed in water but in suitable liquids (e.g. Galden).
- Avoid dewing and condensation.
- Be sure to provide an appropriate fail-safe function to prevent secondary product damage caused by malfunction (e.g. use VDR for limitation of overvoltage condition).



Important notes

The following applies to all products named in this publication:

- 1. Some parts of this publication contain statements about the suitability of our products for certain areas of application. These statements are based on our knowledge of typical requirements that are often placed on our products in the areas of application concerned. We nevertheless expressly point out that such statements cannot be regarded as binding statements about the suitability of our products for a particular customer application. As a rule, EPCOS is either unfamiliar with individual customer applications or less familiar with them than the customers themselves. For these reasons, it is always ultimately incumbent on the customer to check and decide whether an EPCOS product with the properties described in the product specification is suitable for use in a particular customer application.
- 2. We also point out that in individual cases, a malfunction of passive electronic components or failure before the end of their usual service life cannot be completely ruled out in the current state of the art, even if they are operated as specified. In customer applications requiring a very high level of operational safety and especially in customer applications in which the malfunction or failure of a passive electronic component could endanger human life or health (e.g. in accident prevention or life-saving systems), it must therefore be ensured by means of suitable design of the customer application or other action taken by the customer (e.g. installation of protective circuitry or redundancy) that no injury or damage is sustained by third parties in the event of malfunction or failure of a passive electronic component.
- 3. The warnings, cautions and product-specific notes must be observed.
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